

<b>Notice of References Cited</b>	Application/Control No. 10/549,783	Applicant(s)/Patent Under Reexamination SUN, BRIAN	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0126953	07-2003	Kushner, Robert G.	81/3.45
*	B	US-7,069,825	07-2006	Cheung, Chun Ming	81/337
*	C	US-7,069,813	07-2006	Cheung, Chun Ming	81/3.37
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 20219538	4/2003		Warbeg	
	O					
	P					
	Q					
	R					
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1215165	6/2002		Brucart	
	O					
	P					
	Q					
	R					
	S					
	T					

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	O					
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